

CoolMOS[™] **Power Transistor**

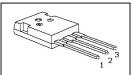
Features

- Worldwide best $R_{\rm ds,on}$ in TO247
- · Low gate charge
- Extreme dv/dt rated
- · High peak current capability
- Qualified according to JEDEC¹⁾ for target applications
- Pb-free lead plating; RoHS compliant

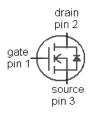
Product Summary

V _{DS}	650	V
R _{DS(on),max}	0.07	Ω
Q _{g,typ}	255	nC

PG-TO247-3-1



Туре	Package	Marking
SPW47N65C3	PG-TO247-3-1	47N65C3



Maximum ratings, at $T_{\rm j}$ =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous drain current	I _D	T _C =25 °C	47	Α
		T _C =100 °C	30	1
Pulsed drain current ²⁾	I _{D,pulse}	T _C =25 °C	141	
Avalanche energy, single pulse	E _{AS}	I _D =3.5 A, V _{DD} =50 V	1800	mJ
Avalanche energy, repetitive $t_{AR}^{2),3)}$	E _{AR}	I _D =7 A, V _{DD} =50 V	1	
Avalanche current, repetitive $t_{AR}^{(2),3)}$	I _{AR}		7	Α
MOSFET dv/dt ruggedness	dv/dt	V _{DS} =0480 V	50	V/ns
Gate source voltage	V_{GS}	static	±20	V
		AC (f>1 Hz)	±30	
Power dissipation	P _{tot}	T _C =25 °C	415	W
Operating and storage temperature	$T_{\rm j}$, $T_{\rm stg}$		-55 150	°C
Mounting torque		M3 and M3.5 screws	60	Ncm



Maximum ratings, at T_j =25 °C, unless otherwise specified

Parameter	Symbol	Conditions	Value	Unit
Continuous diode forward current	Is	т _с =25 °С	47	Α
Diode pulse current ²⁾	I _{S,pulse}	7 _C -25 G	141	

	Parameter	Symbol	Conditions	Values		Unit	
min. typ. max.				min.	typ.	max.	

Thermal characteristics

Thermal resistance, junction - case	R _{thJC}		-	-	0.3	K/W
Thermal resistance, junction - ambient	R _{thJA}	leaded	1	1	62	
Soldering temperature, wavesoldering only allowed at leads	T_{sold}	1.6 mm (0.063 in.) from case for 10 s	1		260	°C

Electrical characteristics, at T_j =25 °C, unless otherwise specified

Static characteristics

Drain-source breakdown voltage	V _{(BR)DSS}	V _{GS} =0 V, I _D =250 μA	650	1	-	V
Gate threshold voltage	$V_{\rm GS(th)}$	$V_{\rm DS} = V_{\rm GS}$, $I_{\rm D} = 2.7$ mA	2.1	3	3.9	
Zero gate voltage drain current	I _{DSS}	V _{DS} =600 V, V _{GS} =0 V, T _j =25 °C	1	0.5	25	μΑ
		V _{DS} =600 V, V _{GS} =0 V, T _j =150 °C	-	50	-	
Gate-source leakage current	I _{GSS}	V _{GS} =20 V, V _{DS} =0 V	-	-	100	nA
Drain-source on-state resistance	R _{DS(on)}	V _{GS} =10 V, I _D =30 A, T _j =25 °C	-	0.06	0.07	Ω
		V _{GS} =10 V, I _D =30 A, T _j =150 °C	-	0.17	-	
Gate resistance	R _G	f=1 MHz, open drain	-	0.75	-	Ω



Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Dynamic characteristics						
Input capacitance	C iss	V _{GS} =0 V, V _{DS} =25 V,	-	7000	-	pF
Output capacitance	C oss	f=1 MHz	-	2300	-	
Effective output capacitance, energy related ⁵⁾	C _{o(er)}	V _{GS} =0 V, V _{DS} =0 V	-	270	-	
Effective output capacitance, time related ⁶⁾	C _{o(tr)}	to 480 V	-	490	-	
Turn-on delay time	t _{d(on)}	$V_{\rm DD}$ =400 V, $V_{\rm GS}$ =10 V, $I_{\rm D}$ =47 A, $R_{\rm G}$ =5.6 Ω	-	100	-	ns
Rise time	t _r		-	27	-	
Turn-off delay time	$t_{d(off)}$		-	210	-	
Fall time	t _f		-	14	-	
Gate Charge Characteristics						
Gate to source charge	Q_{gs}		-	35	-	nC
Gate to drain charge	Q_{gd}	V _{DD} =480 V, I _D =47 A,	-	120	-	
Gate charge total	Q _g	V _{GS} =0 to 10 V	-	255	-	
Gate plateau voltage	V _{plateau}		-	5.5	-	V
Reverse Diode						
Diode forward voltage	V _{SD}	V _{GS} =0 V, I _F =47 A, T _j =25 °C	-	0.9	1.2	V
Reverse recovery time	t _{rr}		-	640	-	ns
Reverse recovery charge	Q _{rr}	V_R =480 V, I_F = I_S , di_F/dt =100 A/ μ s	-	19	-	μC
Peak reverse recovery current	I _{rrm}		-	56	-	Α

¹⁾ J-STD20 and JESD22

²⁾ Pulse width t_p limited by $T_{i,max}$

 $^{^{3)}}$ Repetitive avalanche causes additional power losses that can be calculated as $P_{\rm AV}$ = $E_{\rm AR}$ *f.

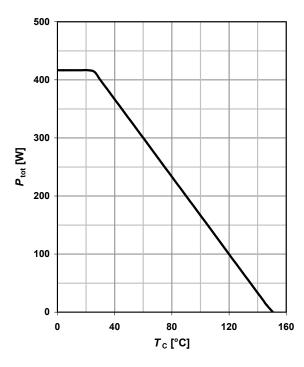
 $^{^{5)}}$ $C_{\rm o(er)}$ is a fixed capacitance that gives the same stored energy as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.

 $^{^{6)}}$ $C_{\rm o(tr)}$ is a fixed capacitance that gives the same charging time as $C_{\rm oss}$ while $V_{\rm DS}$ is rising from 0 to 80% $V_{\rm DSS}$.



1 Power dissipation

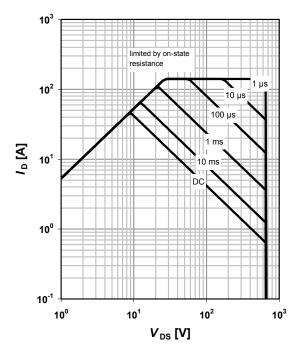
$$P_{\text{tot}}$$
=f(T_{C})



2 Safe operating area

 I_D =f(V_{DS}); T_C =25 °C; D=0

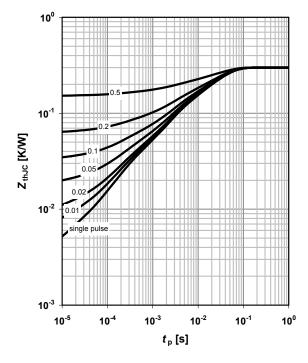
parameter: t_p



3 Max. transient thermal impedance

$Z_{(thJC)} = f(t_p)$

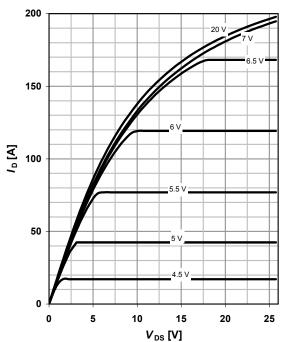
parameter: $D=t_p/T$



4 Typ. output characteristics

 $I_D = f(V_{DS}); T_j = 25 °C$

parameter: V_{GS}

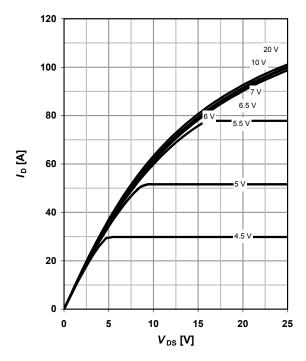




5 Typ. output characteristics

 I_D =f(V_{DS}); T_j =150 °C

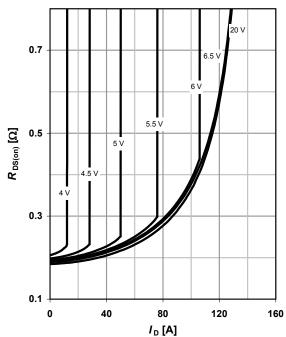
parameter: $V_{\rm GS}$



6 Typ. drain-source on-state resistance

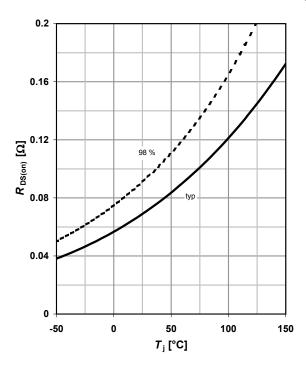
 $R_{DS(on)}$ =f(I_D); T_j =150 °C

parameter: $V_{\rm GS}$



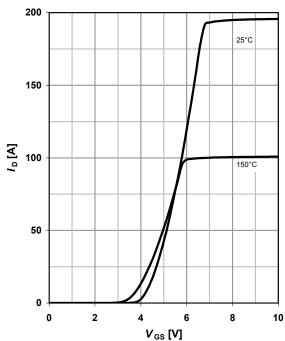
7 Drain-source on-state resistance

 $R_{DS(on)}$ =f(T_i); I_D =30 A; V_{GS} =10 V



8 Typ. transfer characteristics

 $I_{\rm D}$ =f($V_{\rm GS}$); $|V_{\rm DS}|$ >2 $|I_{\rm D}|R_{\rm DS(on)max}$ parameter: $T_{\rm j}$

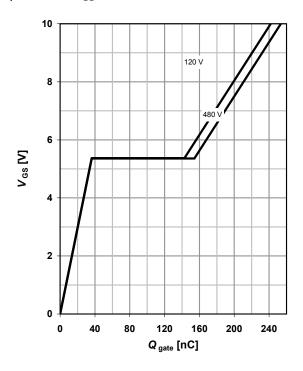




9 Typ. gate charge

 V_{GS} =f(Q_{gate}); I_D =47 A pulsed

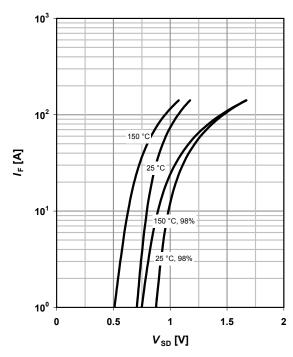
parameter: $V_{\rm DD}$



10 Forward characteristics of reverse diode

 $I_F = f(V_{SD})$

parameter: T_j

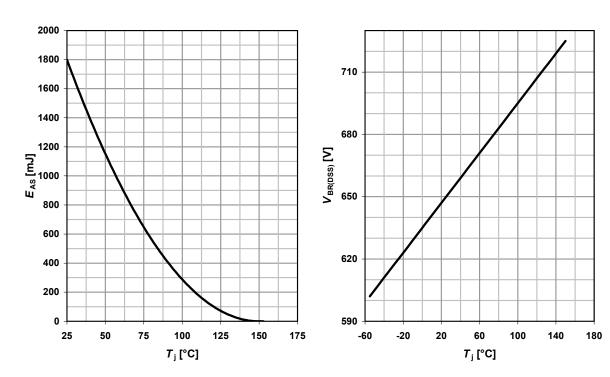


11 Avalanche energy

 E_{AS} =f(T_i); I_D =3.5 A; V_{DD} =50 V

12 Drain-source breakdown voltage

 $V_{BR(DSS)} = f(T_i); I_D = 0.25 \text{ mA}$



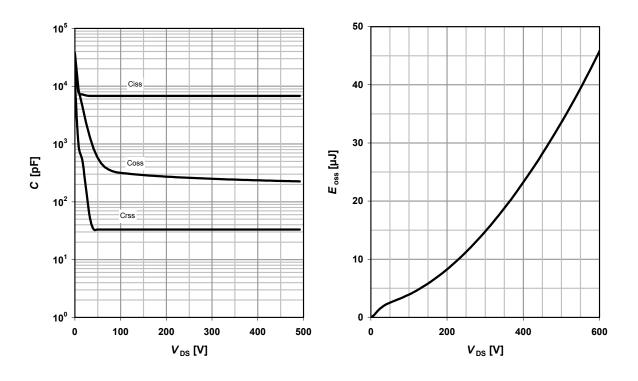


13 Typ. capacitances

$C = f(V_{DS}); V_{GS} = 0 V; f = 1 MHz$

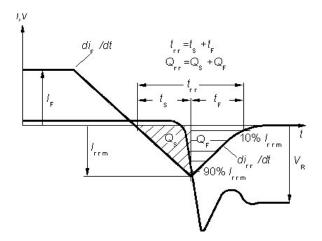
14 Typ. Coss stored energy

$$E_{oss} = f(V_{DS})$$



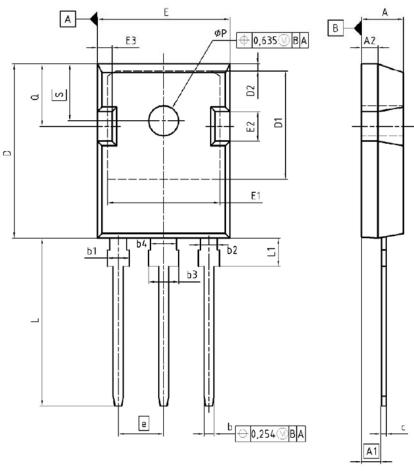


Definition of diode switching characteristics

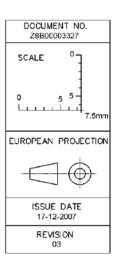




PG-TO-247-3-1: Outlines



DIM	MILLIM	ETERS	INCH	HES	
DIM	MIN	MAX	MIN	MAX	
A	4.90	5.16	0.193	0.203	
A1	2.27	2.53	0.089	0.099	
A2	1.85	2.11	0.073	0.083	
ь	1.07	1.33	0.042	0.052	
b1	1.90	2.41	0.075	0.095	
b2	1.90	2.16	0.075	0.085	
b3	2.87	3.38	0.113	0.133	
b 4	2.87	3.13	0.113	0.123	
С	0.55	0.68	0.022	0.027	
D	20.82	21.10	0.820	0.831	
D1	16.25	17.65	0.640	0.695	
D2	1.05	1.35	0.041	0.053	
E	15.70	16.03	0.618	0.631	
E1	13.10	14.15	0.516	0.557	
E2	3.68	5.10	0.145	0.201	
E3	1.68	2.60	0.066	0.102	
e	5.	44	0.2	214	
N		3		3	
L	19.80	20.31	0.780	0.799	
L1	4.17	4.47	0.164	0.176	
øΡ	3.50	3.70	0.138	0.146	
Q	5.49	8.00	0.216	0.236	
S	6.04	6.30	0.238	0.248	





Published by Infineon Technologies AG 81726 Munich, Germany © 2008 Infineon Technologies AG All Rights Reserved.

Legal Disclaimer

The information given in this document shall in no event be regarded as a guarantee of conditions or characteristics. With respect to any examples or hints given herein, any typical values stated herein and/or any information regarding the application of the device, Infineon Technologies hereby disclaims any and all warranties and liabilities of any kind, including without limitation, warranties of non-infringement of intellectual property rights of any third party.

Information

For further information on technology, delivery terms and conditions and prices, please contact the nearest Infineon Technologies Office (www.infineon.com).

Warnings

Due to technical requirements, components may contain dangerous substances. For information on the types in question, please contact the nearest Infineon Technologies Office. Infineon Technologies components may be used in life-support devices or systems only with the express written approval of Infineon Technologies, if a failure of such components can reasonably be expected to cause the failure of that life-support device or system or to affect the safety or effectiveness of that device or system. Life support devices or systems are intended to be implanted in the human body or to support and/or maintain and sustain and/or protect human life. If they fail, it is reasonable to assume that the health of the user or other persons may be endangered.



New package outlines TO-247

1 New package outlines TO-247

Assembly capacity extension for CoolMOSTM technology products assembled in lead-free package PG-TO247-3 at subcontractor ASE (Weihai) Inc., China (Changes are marked in blue.)

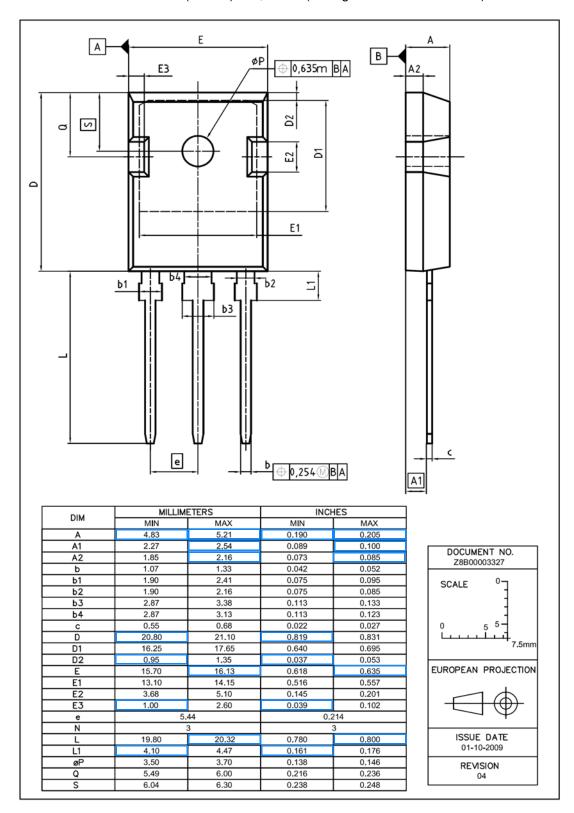


Figure 1 Outlines TO-247, dimensions in mm/inches

Final Data Sheet Erratum Rev. 2.0, 2010-02-01